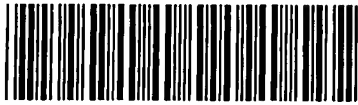


Search Notes

Application/Control No.

10/664,264

Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

WERTENBRUCH ET AL.

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
380	255	7/27/2007	ET
380	257	7/27/2007	ET
380	41	7/27/2007	ET
713	153	7/27/2007	ET

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	7/27/2007	ET
NPL - IEEE XPLORE	7/27/2007	ET